BOICHEV, B., prof.; IKONOMOV, Il.; MATEV, Iv.; MILEV, Tr.; PANEVA-KHOLEVICH, E.; KHOLEVICH, Ia.

Surgery of hand injuries. Khirurgiia, Sofia 13 no.2-3:215-232 160.

(HAND wds & inj.)

MILEV, Trifon Iv. (Sofiya)

Electrotraumatism; according to materials of the Pirogoy Institute of First Aid for 1952-1956. Vop. Elektropat., Elektrotravm. i Elektrobezop. 3:51-59 62. (MIRA 16:12)

(FOOT)

MILEV, T.I.

Trauma of the face and extremities requiring emergency plastic surgery. Acta chir. plast. 4 no.3:227-239 162.

1. Pirogoff Institute for Surgical Emergencies, Sofia (Bulgaria)
Director: Dr. Kh. Zdravkov.

(SURGERY, FLASTIC) (FACIAL INJURIES)

(HAND INJURIES)

EILEV, T. K.

Achieving 501.30 Neters Unidirectional High-speed Driving in Line Galleries (Drifts). Minno Delo (Mining), #2:h6:Feb 55

MILEV, T. K.

Better arched walls for supporting the pits in coal mines. p. 24.

Vol. 10, No. 4, July/August, 1955. MINNO DELO Sofiya, Bulgaria.

SOURCE: East European Accessions List, (EEAL) Library of Congress, Vol. 5, No. 1, January, 1956.

MILEV, Tr., inzh.; SEMKOV, N., inzh.

A

Prospective extraction and dressing of nonferrous cres in 1961-1980. Min delo 17 no.11:17-22 '62.

1. "Kiproruda". Chlenove na Redaktsionnata kolegiia, "Minno delo i metalurgiia."

MILEV, V.; BOGDANOV, I.; GEORGIEV, A.

"On the economic value of lead-zinc deposits."

MINNO DELO, Sofiia, Bulgaria, Vol. 14, no. 2, Mar./Apr. 1959.

بررگ. Monthly list of East Europe Accessions (EEAI), LC, Vol. 8, No. 6, Jun 59, Unclas

MILEV, V.

Some notes on the article by B. Viranev and V. Kurkev. Min delo 18 no.5:46-48 My '63.

1. Upravlenie "TSvetna metalurgiia i rudodobiv."

MILLEY

SHIPKOVENSKI, N., professor; GEORGIEV, Iv.; MILEV, V.

Reflex epilepsy in right cubital osteoarthritis tuberculosa. Suvrem.med., Sofia no.6:97-100 '55.

1. Is Mervnata i psikhiatrichnata klinika pri Visshiia meditsinski institut V.Chervenkov-Sofiia (direktor: prof. G. Usunov)

(TUBERCULOSIS, OSTEOARTICULAR, cubital, with reflex epilepsy)
(EPILEPSY, in tuberculosis, cubital)

MILEY, V.

Certain rules related to the appearance of verbal and auditory hallucinations and their pathophysiology. Suvrem. med., Sofia 9 no.2: 34-42 Feb 58.

1. Iz Psikho-nevrologichnata bolnitsa; Kurilo (Gl. lekar: St. Popov)
(HALLUCINATIONS
auditory & verbal, pathophysiol. (Bul))

Glinicoexperimental method of investigating hallucinations. Ener. nevr. i psikh 58 no.12:1465-1469 '58. (12:1) 1. Psikhonevrologicheskaya bol'nitea (Glavnyy vrach St. Popov), Sofiya. (HALEGINATIONS, clin. & exper. investigations (Rus))

MILEV, V.

On the problem of psychogenic reactions in mental disorders. Suvrem.med., Sofia no.12:32-39 *59.

1. Is psikho-nevrologichnata bolnitsa - Kurilo - Sofiia.
(MENTAL DISORDERS)
(HYSTERIA)

MILEV, Vel'o

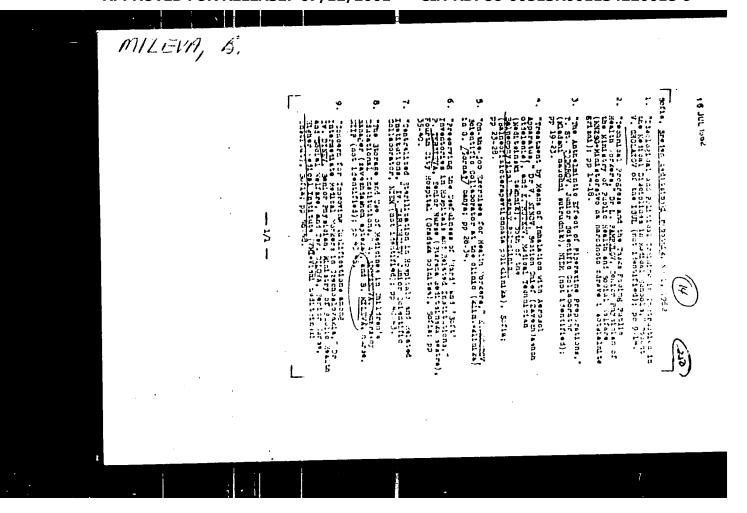
Leveling of rice fields in Bulgaria. Selskostop nauka 1 no.10:1063-1067 *62.

l. Nauchroizsledovatelski institut po zelenchukovi kulturi "Muritsa" v Plovdiv.

MILEV, Vel'o

Timing of rice harvesting, and its influence on grain properties. Selskostop nauka 1 no.6:615-622 *62.

l. Tsentralen nauchnoizsledovatelski institut po zelenchukovi kulturi "Maritsa" v Plovdiv.



APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9"

MILEVA, G.; OBRETENOV, N.; POPOV, M.

Silver minerals from the Chipro tsi deposits, Mikhaylovgrad District. Spis Bulg geol druzh 25 no.3:289-294 '64.

1. "NIPRORUDA" Institute. Submitted February 6, 1964.

MILEVIC, Svetozar, inz. (Beograd)

Measuring low frequencies. Tesla no.13/14:9-14 S-0 155.

MILEVIC, Svetozar, inz. (Beograd)

Synchronization of multivibrators. Tesla no.17/18:18-19 '56.

YUGOSLAVIA/Electricity - General Problems.

G

Abs Jour

: Ref Zhur Fizika, No 12, 1959, 27647

Author

: Milevic Svetozar

Inst Title

: Measurement of Certain Physical Quantities from

a Changing Capacitance

Orig Pub

: Elektrotehn. fak. Univ. Beogradu. Mat. i fiz., 1958,

No 21, 27, 7 s, il.

Abstract

: Certain methods are described for the measurement of small displacements based on the change in the capacitance of a capacitor. In the first method the value of the capacitance is measured with a bridge. In the second method the measured capacitance is a part of a tank circuit. Thus, a change in the magnitude of the capacitance causes a change in the tank-circuit frequency. This change in frequency can be measured by means of a discriminator, heterodyne,

Card 1/2

YUGOSLAVIA/Electricity - General Problems.

G

Abs Jour

: Ref Zhur Fizika, No 12, 1959, 27647

or a special generator. The latter method has an exceedingly high sensitivity. With this method it is possible to measure displacements less than 10-5 cm.

In conclusion, the application of this method is described for the measurement of other quantities

such as temperature, pressure, etc.

Card 2/2

- 72 -

MILEVIC, Systozar, inz.

1

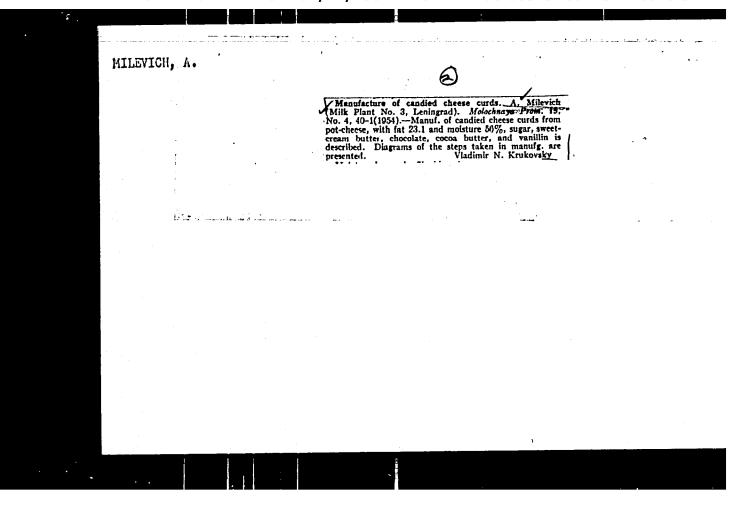
Dynamometer for direct reading of the casting and conveying forces of built-in switches. Zaleznice Jug 19 no.6:1-6 Je 163.

"APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9

Optical and physical properties of stained glass for railroad light signals. Zelezatoe Jug 20 no.3:12-15

Mr 164.

"APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9



MILEVICH, M., agronom

Returns have been hundredfold. Hauka i pered.op.v sel'khos. 9 no.11:16-17 H '59. (MIRA 13:3)

1. Kolkhoz "Peremoga," Tolochinskogo rayona, Vitebskoy oblasti.

(Tolochin District--Pastures and meadows)

HILEVOY, Y.

Rendering an account of cooperative production. p.27. (Ecoperativno Zemedelie Vol. 10, no. 8, Aug. 1955, Sofiya)

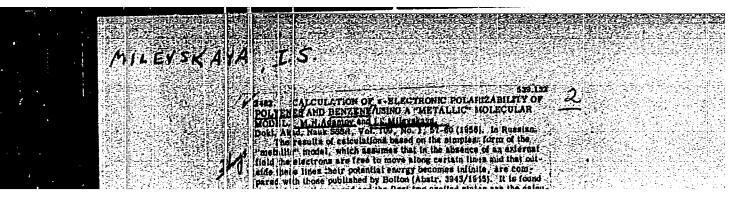
SO: Monthly List of East Wuropean Accessions, (EMAL). LC, Vol. 4, No. 11, Nov. 1955, Uncl.

AFANAS'YEVA, Ye.V.; MILEVSKAYA, I.N.; ISAYEV, D.N.

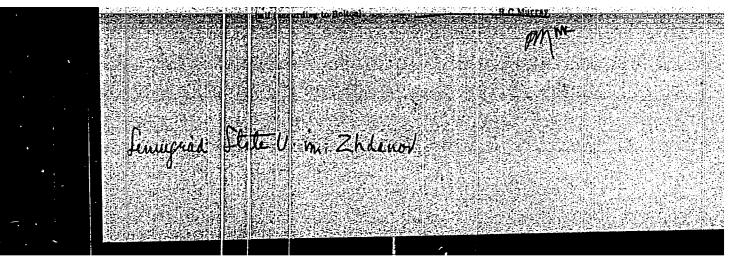
Systematized formation of delirium in adolescents. Zhur.nevr.i psikh. 62 no.7:1038-1043 '62. (MIRA 15:9)

1. Kafedra psikhiatrii (zav. - prof. S.S.Mnukhin) Leningradskogo pediatricheskogo meditsinskogo instituta.
(DELIRIUM) (PERSONALITY, DISORDERS OF)

"APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9



"APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9



MILEY SKAYA, I.S

AUTHORS: Adamov, M. N. and Milevskaya, I. S.

51-3-22/24

TITLE:

Dispersion formula in a metal model of a molecule with conjugated bonds. (Dispersionnaya formula v metallicheskoy

modeli molekuly s sopryazhennymi svyazyami).

PERIODICAL: "Optika i Spektroskopiya" (Optics and Spectroscopy), 1957, Vol.2, No.3, pp. 399-401 (U.S.S.R.)

ABSTRACT: This paper presents quantum-mechanical calculations for T-electron optical polarizability for C2mH2m+2 polyenes

and benzene. The metallic model is used. It is assumed that the many-electron wave-functions can be approximated by an antisymmetrized linear combination of products of orthogonal single-electron wave-functions. Polyene molecules are represented by broken lines lying in one plane whose segment are at 30 with the polyene axis. Each segment is taken to be equal to a (a is the length of the C-C bond, which is 2.6 and end segments are equal to 1.5 a. The electrons are take to move in a rectangular potential box with infinitely high walls. The calculated longitudinal (along the polyene axis, T-electron polarizability for the ground state agrees well with the experimental values for C4H6, C6H8 and C8H10 for the frequency of the D-line of sodium. For C10H12 the

Card 1/2

Dispersion formula in a metal model of a molecule with conjugated bonds. (Cont.) 51-3-22/24 calculated value is 10 times too large because the frequency of the D-line of sodium is close to the natural frequency of an allowed $C_{10}H_{12}$ electronic transition. The benzene molecule is represented by a circle of radius R = 3a/T, where again a = the length of the C-C bond. The results for the polarizability at the D-line of sodium agree well with the experimental values. There are 2 tables and 4 references, 3 of which are Slavic.

SUBMITTED: October 12, 1956.

ASSOCIATION: Physics Department, Leningrad State University.
(Fizicheskiy Fakul'tet Leningradskogo Gosudarstvennogo Universiteta).

AVAILABLE:

Card 2/2

KHACHKURUZOV, G.A.; MILEVSKAYA, I.S. (Leningrad)

Calculation of thermodynamic functions for polyatomic gases with nonrigid molecules. Part 1: General theory. Zhur. fiz. khim. 34 no. 11:2554-2560 N '60. (MIRA 14:1)

1. Gosudarstvennyy institut prikladnoy khimii. (Thermodynamics) (Gases)

MILEVSKAYA, I.S.; VOL'KENSHTEYH, M.V.

Determination of macroradical conformations from spectra of electron paramagnetic resonance (EPR), Opt. i spektr. 11 no.3:349-352 S '61. (MIRA 14:9) (Paramagnetic resonance and relaxation) (Radicals (Chemistry))

KHACHKURUZOV, G.A.; MILEVSKAYA, I.S.

Calculation of the thermodynamic functions of polyatomic gases with nonrigid molecules. Part 2: Monlinear symmetrical molecules IY2. Zhur. fiz. khim. 35 no.1:142-151 Ja '61. (MIRA 14:2)

1. Gosudarstvennyy institut prikladnoy khimii, Leningrad. (Thermodynamics) (Molecules)

5,4600

36495

\$/051/62/012/003/004/016

E202/E192

AUTHORS:

Milevskaya, I.S., and Vol'kenshteyn, M.V.

TITLE:

E.p.r. spectra of polystyrene radicals

PERIODICAL: Optika i spektroskopiya, v.12, no.3, 1962, 381-386

Detailed quantum mechanics calculations of the spin density distribution of radicals formed during mechanical destruction and irradiation of polystyrene are given. Three types of radicals are discussed, as shown below. Types I and II were further subdivided and studied according to whether the A and B atoms are coplanar with the phenyl ring while the \mathfrak{N} electrons of the ring and the unpaired electron form a single system, or whether the plane of the ring is turned by 90° about the C_0C_1 axis, viz:

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APPROVED FOR RELEASE: 07/12/2001

CIA-RDP86-00513R001134220018-9"

E.p.r. spectra of polystyrene ... 5/051/62/012/003/004/016 E202/E192

Experimental evidence was given suggesting also the presence of type III, to which a special attention was given. In the calculation of its spin density only σ -electrons of the phenyl ring were considered, taking altogether seven valency structures. The spin density (calculated from the wave function) gave at the hydrogen atoms closest to the unpaired electron $\varrho_{\rm H} = -0.096$, which corresponded to the splitting on these protons of $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the present authors (Ref.1: $\varrho_{\rm H} = 49$ gauss, as previously given by the graph grap

SUBMITTED: March 22, 1961

Card 3/3

\$/194/62/000/007/077/160 D295/D308

AUTHORS:

Kosolapova, E.F., and Milevskaya, N.G.

TITLE:

The coefficient of linear expansion of certain mate-

rials for semiconductor thermo-elements

PERIODICAL:

Referativnyy zhurnal. Avtomatika i radioelektronika, no. 7, 1962, abstract 7-4-69 shch (In collection: Tep-

loenergetika, no. 3, M., AN SSSR, 1961, 58-60)

TEXT: The authors have investigated the coefficient of linear expansion of alloys prepared by high-temperature sintering and by melting in quartz vessels in vacuum up to 0.06 mm Hg. Bi₂Te₃ - Sb₂Te₃, PbTe, Bi₂Te₃, CoSb₃, ZnSb and the commutation alloy Ni-Bi were prepared by hot pressing. The pressure during preparation was 170 kg/cm², temperature 3500C, pressure being maintained for 3 min. The coefficient of linear expansion was investigated up to 400°C. Measurements were made by means of a quartz dilatometer. The sample placed in a quartz vessel, was pressed against its bottom by a quartz rod. The sample temperature was measured by a chromel alumel Card 1/2

The coefficient of linear expansion ... S/194/62/000/007/077/160

thermocouple. The length increase of the samples was plotted as a function of temperature. Some alloys (PbTe, Bi₂Te₃ and Bi₂Te₃ - Sb₂Te₃) were also prepared by melting powders in a quartz vessel at 6 x 10-2 mm Hg. Samples of ~16 mm length were prepared from the ingots obtained. The PbTe alloy has the largest coefficient of linear expansion. For its thermoelectric properties PbTe is the best negative branch. Its coefficient of linear expansion is however large in comparison with a Bi₂Te₃ - Sb₂Te₃ positive branch. The temperature of the hot junction for the pressed couple Bi₂Te₃ - Sb₂Te₃ - Bi₂Te₃ must be <370°C and for the cast alloy <400°C. The CoSb₃ - ZnSb couple can work with a corresponding commutation alloy up to nearly 400°C. Temperature dependence of the coefficient of linear expansion are given and recommendations are given on the use of alloys in thermoelements. 3 references. [Abstracter's note: Complete translation.]

card 2/2

MILEVSKAYA, V.G.

AUTHORS: Panin, V. Ye. and Milevskaya, V. G.

126-1-18/40

TITLE:

On the problem of the latent, deformation energy of alloys of solid solutions. (K voprosu o skrytoy energii deformatsii splavov tverdykh rastvorov).

PERIODICAL: Fizika Metallov i Metallovedeniye, 1957, Vol.5, No.1, pp. 120-126 (USSR)

Fedorov, A. A. has shown (Ref.1) that for pure metals ABSTRACT: with an equal crystal structure a certain relation exists between the melting temperature and the magnitude of the latent deformation energy; the latter will be the higher the higher the melting temperature of the material. This phenomenon is attributed to the fact that with increasing melting point temperature the intensity of relaxation decreases during deformation, which leads to an additional accumulation of deformational lattice distortions. The picture is much more complicated for alloys than it is for pure metals; in this paper only those alloys are dealt with which represent solid solutions. As a result of the presence in the lattice of the solvent metal of atoms of the other component, the lattice of the alloy is strongly distorted even in the annealed state and the Card 1/5 sliding conditions in it become more complicated.

Therefore, the magnitude of the latent deformation energy

CIA-RDP86-00513R001134220018-9" APPROVED FOR RELEASE: 07/12/2001

126-1-18/40 On the problem of the latent deformation energy of alloys of solid solutions.

as well as the resistance to deformation should be larger than in the pure solvent even if the latter has a higher This idea was first expressed by melting point. M. A. Bol'shanina (Ref.2) and was partly verified by N. V. Tyzhnova (Ref.3). Tyzhnova investigated Cu-Ni alloys containing 10, 30, 50 and 70% Ni and also pure copper. The deformation was effected by compression. Some of her results are graphed in Fig.l of this paper. As was to be anticipated, the absorbed energy in the alloys is considerably higher than in pure copper. Thereby, the magnitude of the latent energy increases monotonously with increasing nickel content. The authors of this paper believe that the latent energy cannot increase monotonously with increasing nickel content and that this should apply only for nickel contents up to 50% when the lattice of the alloy has a minimum distortic Further increase of the nickel content reduces the conter of copper atoms in the nickel and this should lead to a decrease in the degree of deformation of the lattice of the solvent metal and thus also to a decrease of the Card 2/5 latent deformation energy. Therefore, when changing the

126-1-18/40

On the problem of the latent deformation energy of alloys of solid solutions.

> concentration of the Cu-Ni alloy the latent deformation energy should change along a curve, the maximum of which is in the medium range of concentrations. Tyzhnova did not obtain such a curve because in the second half of the system she only investigated the single alloy containing 70% Ni. Also she did not investigate pure nickel and comparison of the results obtained for pure copper with those obtained for Cu-Ni alloys is not quite appropriat owing to the lower melting point of the copper. verifying the here expressed views, the authors investigated pure nickel and pure copper and also alloys containing 40, 60 and 80% Ni, the exact analyses of which are given in a table, p.122. Furthermore, they investigated a copper-zinc alloy containing 61.20% Cu, 38.61% Sn without any Pb and Mn contents; this alloy was chosen because its melting point is lower than that of The magnitude of the latent energy was determined as the difference between the plastic deformation work and the heat generated during the deformation, a method described by various authors (Refs.1-3). The scattering of the values of the absorbed energy amounts to 1-2%;

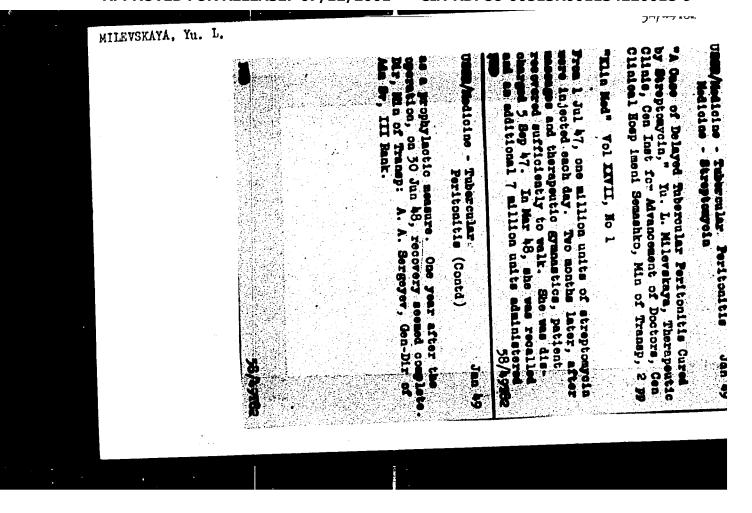
Card 3/5 owing to the nonuniform distribution of the temperature

On the problem of the latent deformation energy of alloys of solid solutions.

at the contacting surfaces, there was a systematic error as a result of which the energy values were 10 to 12% too high. Since this error applies to all the results, it is of no consequence from the point of view of studying relative relations. The results are graphed in Figs. 2-6 and it can be clearly seen that the individual curves have fairly pronounced maxima. The following conclusion are arrived at. The latent deformation energy of solid solutions with unlimited solubility of the system Cu-Ni changes with the composition of the alloy in accordance with a curve with a maximum which passes through the medium range of concentrations. This corresponds with changes in the hardness, the electric resistance, the dynamic coefficient, the thermo e.m.f. and other characteristics which depend on the composition. On changing over from pure copper to brass 162, which is an α -solid solution of limited solubility, the latent deformation energy increases. The increase of the absorbed energy with increasing deformation is considerably larger for brass than it is for alloys of copper with nickel. A correspondence between the flow curves

Card 4/5

Card 5/5



MILEVSKAYA, Yu.L.

Rational therapy of lobar pneumonia. Klin.med., Moskva 29 no.4: 30-33 Apr 1951. (CIML 20:9)

1. Of the Therapeutic Clinic (Head--Honored Worker in Science Prof. I.A. Kassirskiy), Central Institute for the Advanced Training of Physicians, attached to the Central Clinical Hospital imeni Semashko of the Ministry of Ways of Communication (Director G.A. Zhdanov).

hilmvohnin, Iv. L.

USSR/Medicine - Chemotherapy, Combination

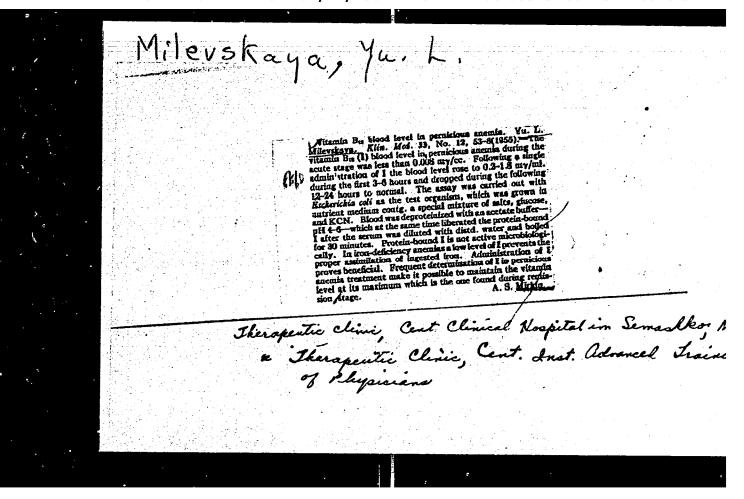
Jsn 55

"Combination Treatment With Antibiotics," Prof. I. A. Kashirskiy, I. I. Poroshina, and Yu. L. Milevskaya (Moscow), Therapeutic Clinic, Central Institute for Advanced Training of Physicians

Klin Med, No 1, Vol 31, pp 14-25

Experimental and clinical data confirm the suitability of combination treatment of infectious or septic diseases with antibiotics. Two or more chemotherapeutic agents, each acting differently on the microorganisms, produce both the bacteriostatic and the bactericidal action; this action is more rapid and lasting than that due to the effects of one of these chemical prepns alone.

PA 255T23



MILEVSKAYA, Yu. L., Cand Med Sci -- (diss) "Tretament of patients with pernicious anemia Vitamin B₁₂." Mos, 1957.

16 pp (Min of Health USSR, Central Inst for Advanced Training of Physicians), 200 copies (KL, 2-58, 116)

-72-

USSR/Pharmacology. Toxicology. Vitamins.

٧

Abs Jour: Ref. Zhur. - Biol., No 22, 1958, 102879

Author : Milevskaya, Yu. L.

Inst:

Title : On the Expediency of Application of Large Doses

of Vitamin B12.

Orig Pub: Klinich. meditsina, 1958, 36, No. 3, 93-97.

Abstract: On the basis of 3-year-long observations of a

group of patients (38) with pernicious anemia, the conclusion is made that a good therapeutic effect in uncomplicated pernicious anemia is induced by the introduction of moderate doses of vitamin B_{12} (15-40 gamma) daily or every 1-2 days. The introduction of large doses of B_{12} (over 200 gamma) is not expedient, since in such

Card 1/2

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MILEVSKAYA, Yudif' L'vovna

[Vitamin B₁₂ and its significance in the pathogenesis and treatment of pernicious anemia] Vitamin B₁₂ i ego znachenie v patogeneze i lechenii pernitsioznoi anemii. Moskva, Medgiz, 1960. 134 p. (MIRA 13:12)

(ANEMIA) (CYANOCOBALAMINE)

MILEVSKAYA, Yu.L., kand.med.nauk

Vitamins and the blood. Zdorov'e 8 no.8:4-5 Ag '62. (MIRA 15:8) (VITAMINS) BLOOD)

RABUKHIN, A. We.; MILEVSKAYA, Yu.L.

Climical aspects of cardiac lesions in tuberculosis. Terap.arkh.
34 no.2:13-20 *62. (MIRA 15:3)

KASSIRSKIY, I.A.; MILEVSKAYA, Yu.L. (Moskva)

Controversial questions in antibiotic therapy. Terap. arkh. 35 no.219-16'63. (MIRA 16:10) (ANTIBIOTICS)

VISHNEVETSKIY, V.; MILEVSKIY, B.

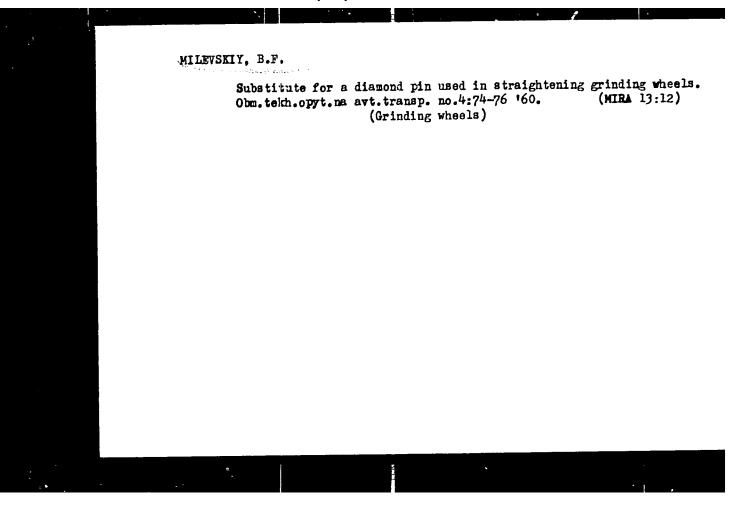
The 367M-type oil distributor. Avt. transp. 36 no.5:9-10 My '58.

(Service Stations) (MIRA 11:6)

VISHNEVETSKIY, V.; MILEVSKIY, B., inzh.

Equipment for washing motor-vehicle parts. Avt. transp. 38
no. 12:28-29 D *60. (MIRA 13:12)

(Motor vehicles -- Maintenance and repair)



DUNAYEVA, N.1.; MILEVSKIY, B.F.

Feorle of a prestive mind. Meta: urg 10 no.8:3-4 ag 15.

1. Nachal'nik Byuro po ratsionalizatsii i izobretatel'stvu Cherepovetskogo metallargichsäkago zavoda (for Dunayeva).

2. Predsedatel' Vessyurnogo obshchestva izobretabley i ratsionalizatorov (for Milevsky).

MILEVSKIY D.

BULGARIA/Chemical Technology. Chemical Products and Their I-8
Application. Ceramics. Glass. Binders. Concrete.

Abs Jour : Ref Zhur-Khimiya, No 2, 1958, 5341.

Author : Money G., Videnova R., Milevskiy D.

Inst : Institute of Mining Geology.

Title : Quartzites of Lozenska Mountain as Kinas Raw

Material.

Orig Pub : Godishnik Minno-geol. in-t, 1954-1955, (1956),

2, No 1, 169-178.

Abstract : A study of 3 varieties of crystalline quartzites from 3 deposits of Lozenska mountain (Bulgaria)

-dark red, pink and light grey, containing (in % by weight): SiO₂94.7-97. .8, Al₂O₂ 1.94-1.15, Fe₂O₃ 0.6-2.3, R₂O 0.22-0.84; volumetric weight

Card : 1/3

Card : 2/3

BULGARIA/Chemical Technology. Chemical Products and Their I-Application. Ceramics. Glass. Binders. Concrete.

Abs Jour

Ref Zhur-Khimiya, No 2, 1958, 5341.

Abstract

The best specimens were found to be those made from a mixture of Lozenska and Troyansko quartizites (specific gravity 2.37, compression

201 kg/cm²). According to the data listed the Dinas thus obtained meets the specifications of Grade II Gost USSR. As a result of the work the conclusion is arrived at that quartzites of Lozenska mountain, particularly in admixture with Troyansko quartzites, can be utilized to establish the manufacture of Dinas in Bulgaria, where it has not been produced hitherto.

Card

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1.8000

5/194/62/000/006/037/232 D295/D308

AUTHOR:

Milevskiy, E.B.

TITLE:

On the linearity of the readings in radiation measurements of parameters of machine elements in the process of their production

PERIODICAL: Referativnyy zhurnal. Avtomatika i radioelektronika, no. 6, 1962, abstract 6-3-76 f (Nauchn. zap. L'vovsk. politekhn. in-t, no. 78, 1961, 210-225)

TEXT: In the control and measurement, by means of radioactive irradiation, of the linear dimensions of machine elements in the process of their production (in motion, oscillation etc.), error arise owing to the existence of non-linearity between the increments of the readings of detectors and the increments of the linear dimensions of machine elements. The regions of linear dependence are investigated by geometrical-optics methods when two radiators and two detectors are used for the measurement. It is found that improved linearity can be achieved in rational measuring by designing the source-detector scheme in accordance with notions of geometrical Card 1/2

On the linearity of the readings ...

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optics and by improving the geometry of source and detector, by decreasing the solving time of the counters and recording equipment, by using mono-crystals with small luminescence-decay time as detectors and by using a photo-electron multiplier with large multiplication coefficient and small load. 10 figures and 3 references. [Abstractor's note: Complete translation.]

Onrd 2/2

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S/263/62/000/010/004/013

1028/1250

AUTHOR:

Milevskiy, E. B.

TITLE:

Measurement errors in the radiation control of wall differences of an article in a

differential circuit

PERIODICAL:

Referativnyy zhurnal, otdel'nyy vypusk. 32. Izmeritel'naya tekhnika, no. 10, 1962, 18,

abstract 32.10.132. "Nauchn. zap. L'vovsk. politekhn. in-t", no. 79 1961, 269-280

TEXT: The increase in the statistical errors caused by the discrete character of nuclear radiation and the wall differences of the article are determined analytically, and a criterion for the applicability of the radiation method to the control and measurement of the wall differences of the article is established. Results of the investigation show that: 1) the differential measuring circuit decreases considerably the measurement error relative to the direct circuit; 2) in designing radiation instruments operating by the differential circuit it is necessary to take into account the increase of statistical errors caused by statistical fluctuations and the difference in the thickness of the wall, which increases the absolute error of the measurements; 3) the increase of statistical error's as a part of the measuring error, for given circuit sensitivity, wall difference, and linear absorption coefficient, can be reduced by using a high-activity source or by increasing the constant measuring time

Card 1/2

Measurement errors in..

S/263/62/0000/010/004/013
1028/1228

A compensation measuring circuit is recommended in order to decrease the effect of the statistical and instrumental errors. There are 6 figures, and 11 references.

[Abstracter's note: Complete translation.]

17.1450

39591 S/263/62/000/011/003/022

1007/1207

AUTHOR:

Milevskiy, E. B.

TITLE:

The effect of self absorption of radiations in a radiation source used for measurements

PERIODICAL:

Referativnyy zhurnal, otdel'nyy vypusk. 32. Izmeritel'naya tekhnika, no. 11, 1962, 14. abstract 32.11.84. "Dokl. Lvovsk. politekhn. in-ta", v. 5, no. 1. Mekhanika, 286-292

TEXT: The design of radioactive measurement devices of definite statistical error involves: determination of the optimum quantity of radiosotopes in order to select an optimum thickness of the radiation source for detection purposes; establishing the specific activity of the source, and protection of the staff from radiation hazards. A thin layer of metallic Tl^{204} isotope is used as a β -ray emitter, having a radiant energy of 0.76 Mev. With the increase in the layer thickness, the amount of γ -radiation in the β -spectrum increases as a result of complete absorption of β -particles by the radiation source, and the Tl²⁰⁴ gradually becomes an emitter of γ -radiations with an energy of 0.0076 to 0.76 Mev. With the change in the layer thickness of the Tl²⁰⁴ emitter, the activity of the latter, after a sudden increase, then diminishes, asymptotically approaching a constant value — the field of saturation. Thus, for instance, when the layer thickness increases from 0.5 to 1 mm, the radiation activity increases by 250%, whereas at an increase from 2 to 2.5 mm, the activity increases by 50%. The study of self-absorption of an infinite lamella shows that the density of the radiant flux on the source surface has a limiting value that depends on the specific activity and absorption coefficient of the source. In cases where

The effect of self-absorption of...

S/263/62/000/011/003/022 I007/I207

 β or γ -radiations are emitted by a source of large layer thickness, the degree of absorption depends on the energy of the β and γ -radiations. The larger the thickness of the β -source that fully absorbs electrons, the smaller the measuring sensitivity. The author devises formulae for computing such a layer thickness that ensures retention of β -radiations; he further describes the absorption of β -rays by sources of varying layer thickness. He shows that, when using a radiation source of infinite thickness, the counting speed is proportional to the ratio between the amount of radioactive material and the amount of inactive material whereas, in the case of a thin radioactive source, the counting speed is proportional to the amount of active material. There are 5 figures and 6 references

[Abstracter's note: Complete translation.]

Card 2/2

"APPROVED FOR RELEASE: 07/12/2001

CIA-RDP86-00513R001134220018-9

S/263/62/000/011/004/022 I007/I207

AUTHOR:

Milevskiy, E. B.

TITLE:

Radioactive measurements of the diameter of large-size components

PERIODICAL:

Referativnyy zhurnal, otdel'nyy vypusk. 32. Izmeritel'naya tekhnika, no. 11, 1962, 14, abstract 32.11.86. "Dokl. L'vovsk. politekhn. in-ta", v. 5, no. 1, Mekhanika, 293-302

TEXT: Radioactive measurement of the diameter of large-size components may be carried out by determining either the gain in diameter or the absolute value of the latter. In the first case, the following scheme may be used: one radiation source (RS) and one radiation detector. According to the scheme a narrow beam of parallel radiations passing through a collimator mounted on the RS, is sent tangentially to the surface of the component (part of the beam is covered by the component) and, after passing through another collimator is received by a detector. The gain in diameter causes reduction or increase in the intensity of the radiation flux received by the detector; the intensity variations are recorded by an electronic computing device (system). However, vibrations of the component, particularly those of low frequency, increase the inertia of the measuring device, leading to reduction of its sensitivity accuracy, and speed of measurements. Large vibration amplitudes require a considerable increase in the beam width and hence particular attention to the geometrical shape of

Card 1/2

Radioactive measurements of...

\$/263/62/000/011/004/022 1007/1207

the RS. The scheme, two RS and two detectors, permits the measurement of the gain in diameter or its absolute value for components subjected to vibrations, movement, or displacement of the centerline. The axes of each RS-detector group are parallel over a distance equal to the rated diameter of the component; the groups are mounted asymmetrically with respect to the vertical diameter of the component, and from two wide, divergent radiation-beams oriented in opposite directions. Both detectors are connected to a pulse-counting device that gives summation of readings. The readings vary with the changes in the component sizes, and are approximated by nonlinear curves. Despite some deficiencies, the method of radioactive diameter-measurement for large-size parts permits the recording of changes in the diameter caused by deposition of vapor, dust and cooling liquid even for components subjected to vibrations.

[Abstracter's note: Complete translation.]

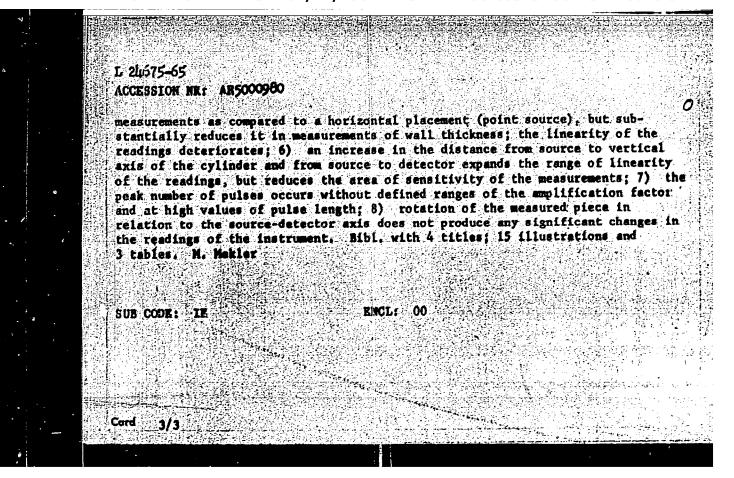
Card 2/2

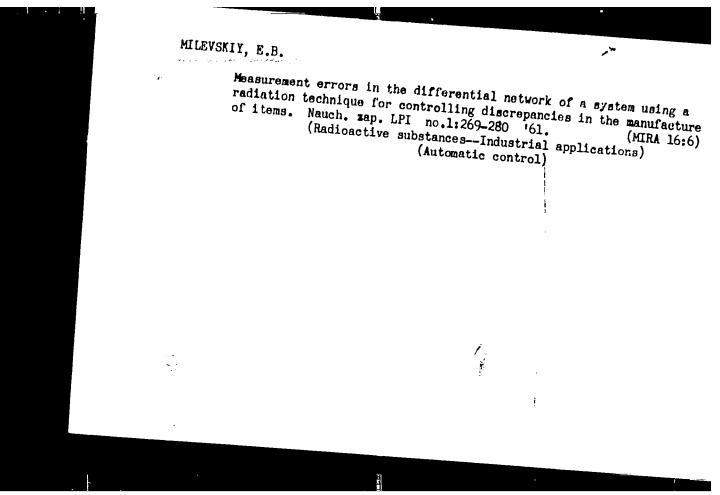
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ACCESSION NR: AR5000980	
	8/0272/64/000/009/0032/0032
9.32.209	i immeritel naya tekhnika. Otd. vyp., Abs.
AUTHM: Milevskiy, E. B.	25
measurement of a workpiece	ric parameters of a radiation setup on the
CITER SOURCE: Sb. nauchn. rai	out aspirantov L'vovsk. politekhn. in-ta., no. 2,
1963 LO-167	OM
ment, hollow Break Automatem	ment, geometric parameter, wall thickness measure
measurement linearity, point a impedance screen, collimating	measurement sensitivity
TRANSIATION: The article cite parameters in a radiation setu hollow cylindels:	s experimental data on the effects of geometric for measuring the dismeter and wall thickness of well as the effects of contour and dimensions of self-thickness of the measurements. A
Cord 1/3	and linearity of the measurements. A
*	

L 24675-65

ACCESSION NR: AR5000380

laboratory setup for measuring the diameter and wall thickness of a steel cylinder is described and analysed. The sensitivity and linearity of a counter's readings were found to vary during the experiments depending on: 1) distance between the source and the vertical axis of a cylinder; 2) distance between the source and detector; 3) width of collimating slit; 4) length and positioning of the source (wire, plate, capsule); 5) configuration of the collimator; 6) angle between the cylinder axis and the source-detector axis; 7) presence of artificial obstacles in the beam's path; 8) isotopes used in the experiment. The experimental results and their analysis served as the basis for the following conclusions: 1) the linearity and sensitivity of readings improve as the dimensions of the light source increase; 2) a reduction in the size of the collimating slit in the detector and the source improved the sensitivity of diameter measurement, but narrows the range of its linearity and lessens the sensitivity of measurements of wall thickness; 3) placement of profiled screens in the beam's path acts to increase substantially the linearity range in measurements of wall thickness and to decrease it in gaging diameters; the sensitivity increases in all cases; 4) the number of recorded pulses can be increased and the linearity and sensitivity of measurements improved by reducing the dismeter or wall thickness dimension gain area in relation to the size of the light source; 5) a vertical placement of (extended) beta or gamma sources improves the sensitivity of diameter





MILEVSKIY Eduard Borisovich; MARKOVSKIY, Ye.A., kand. tekhn.nauk, red.; retsenzent; RABINOVICH, A.N., prof., doktor tekhn.nauk, red.; CHISTYAKOVA, L.G., inzh., red.; GORNOSTAYPOL'SKAYA, M.S., tekhn. red.

[Radiation check and measurement of workpieces] Radiatsionnyi kontrol' i izmerenie izdelii. Moskva, Mashgiz, 1963. 129 p. (MIRA 16:6)

(Radioisotopes -- Industrial applications)
(Engineering inspection)

APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9"

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SOURCE CODE: UR/0272/66/000/008/0032/0032 ACC NR: AR6034972

AUTHOR: Milevskiy, E. B.

TITLE: Conditions for obtaining minimal noise in an electronic circuit which measures dimensions by means of radiation

SOURCE: Ref. zh. Metrologiya i izmeritel'naya tekhnika, Abs. 8.32.255

REF SOURCE: Kontrol'no-izmerit. tekhnika. Resp. mezhved. nauchno-tekhn. sb., vyp. 1, 1965, 116-122

TOPIC TAGS: measurement, electronic circuit, radioisotope, signal to noise ratio electric measuring instrument

ABSTRACT: Conditions for obtaining minimal noise in an electronic circuit which measures dimensions by means of radioisotope radiation are studied. The dependence of noise pulses on the amplification factor, the discrimination threshold and the photomultiplier voltage as well as the ratio between operating and noise pulses are investigated. Six illustrations. [Translation of abstract] [DW]

SUB CODE: 09, 14/

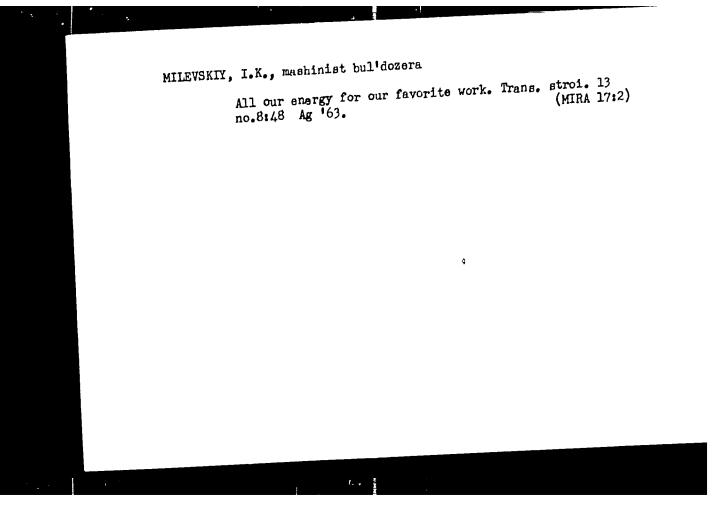
UDC: 621, 391, 82;531, 717 Card 1/1

	C(m)/EWP(V)/EWP(E)/EWP(F)/EWP(D) UR/0137/66/000/002/D033/D033
L 04684-67 EWT(3)71	SOURCE CODE: UR/0137/66/000/002/p033/D033
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AUTHOR: Milevskiy, E	B. R
A summer of n	iation devices for the automatic control of dimensions
SOURCE: Ref. zh. Het	lurg, Abs. 2D228
REF SOURCE: Avtomatinauchno-tekhn. sb., v	proizv. protsessov v mashinostr. l priborostr. Mezhved. resp. 2, 1965, 113-131
TOPIC TAGS: radiation	instrument, beta radiation, gamma radiation
TRANSLATION: A survey tion devices for auto- ing questions are com- by means of redistion 2) controlling of man	based on Soviet and foreign literature is made of various radia- ntic dimension control used in the rolling industry. The follow- idered in detail: 1) controlling of sheet and plate thickness absorption (beta-thickness gages, gamma-alpha-thickness gages); absorption (beta-thickness gages, gamma-alpha-thickness gages); rial and coating thickness by an x-ray method; 3) controlling of rial and coating thickness by an x-ray method; 3) controlling of kness by measuring back-scattered radiation. Schematics of and f these devices are presented in detail. N. Yudina.
SUB CODE: 18,13	•
	UDC: 621.771.24.004.5
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L 34787-66	Ell'(u)	SOURCE CODE:	UR/0058/65/000/012/A063/A06
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AUTHOR: TITLE: SOURCE: REF SOUR TOPIC TA Beta rad ABSTRACT selectin ments of serves the cal weight. system for the radioac	The design of the input the type of nuclear radius the recording device, as the source of energy foulation includes also the It is noted that radious have been obtained by now construction of radiation the isotopes from all positive isotopes from all positive them.	tekhn. in-ta, no. 4, 19 at, radiation detector, at unit of a radiation diation and radioactive and the corresponding ce or the sensitive element e determination of the active isotopes of all and the connection, and devices to be able to or the radioactive isoto at the radioactive isoto	iation measuring circuit
and th		ion, cost of reason	

metal content of the shielding equipment. The type of nuclear radiation determines in many ways the choice of the converter (detector) of radio-isotope radiation into in many ways the choice of the converter and converters are gas-discharge are electric pulses. Most frequently the detectors and converters are gas-discharge are electric pulses. Most frequently the detectors most frequently used in scintillation detectors.	L 34787-66
scintillation counters. General tectors are considered. L. S. [Translation of abstract] SUB CODE: 20	metal content of the shielding equipment. The type of nuclear radiation determines in many ways the choice of the converter (detector) of radio-isotope radiation into electric pulses. Most frequently the detectors and converters are gas-discharge are electric pulses. Most frequently the detectors most frequently used in scintillation descintillation counters. Certain phosphors most frequently used in scintillation descintillation counters. [Translation of abstract]
Card 2/2 W	Cord 2/2 W



"APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9

24.7100

76007 507/76-4-5-29/36

AUTHOR:

Milevskiy, L. S.

TITLE:

Interaction of Dislocations in Silicon as Observed After

Staining

PERIODICAL:

Kristallografiya, 1959, Vol 4, Nr 5, pp 785-786 (USSR)

ABSTRACT:

The theoretical concepts suggested by W. T. Read and A. Cottrell on intersecting slip planes, their tangling up, interference, orientation, bending, the resulting lattic vacancies, kinks, and the open loops of dislocations are cited. Friction at intersecting slip planes that lead to beinding of a moving dislocation and to a semiloop of dislocation is confirmed by the author in artificial. grown silicon crystals. Having stained the slip planes by copper deposited in lattice vacancies along the surfaces of four different dislocations, he took photograp of the colored bands by an infrared microscope. The photographs showed bent slip surfaces near the intersections, and extensive straight planes beginning at a

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Interaction of Dislocations in Silicon as Observed After Staining

76007 507/70-4-5-29/36

certain distance from the intersections. The copper deposition was not continuous along the straight planes but was confined to the parts representing screw dislocations with concentrated vanancies at small steps. At the intersection of four or more synchronic slip surfaces, the deposited copper formed a dense and manifold branched cloud. This kind of tangled dislocations seems to produce more spots of condensed vacancies Thus, staining permits one to visualize the dislocations and to get information concerning their interactions and V. L. Indenbom is acknowledged for reviewing the article and for discussions. There are 3 figures; and 3 references, 2 U.S., 1 U.K. They are: W. T. Read, Dislocations in Crystals, 1953; W. C. Dash, J. Appl. Phys., 27, 10, 1193, 1956; A H. Cottrell, Dislocations and Plastic Flow in Crystals, 1953.

ASSOCIATION:

Metallurgical Institute imeni A. A. Baykov (Institut

metallurgii imeni A. A. Baykova)

April 21, 1959 SUBMITTED:

Card 2/2

CIA-RDP86-00513R001134220018-9" APPROVED FOR RELEASE: 07/12/2001

s/181/60/002/009/012/036 B004/B056

9.4300 (1035,1138,1143)

AUTHORS:

Akimchenko, I. P., Milevskiy,

TITLE:

The Diffusion of Antimony in Germanium Alloyed With

Aluminum

PERIODICAL:

Fizika tverdogo tela, 1960, Vol. 2, No. 9, pp. 2109 - 2116

TEXT: The authors discuss the results obtained by some papers published on the diffusion of impurities in germanium (Refs. 1-5). B. I. Boltaks (Ref. 5) determined the "Diffusion Isothermal Lines" for the diffusion of antimony in germanium alloyed with antimony. The present paper aimed at determining the diffusion isothermal lines for antimony, in which case, however, the Ge was alloyed with an acceptor, viz., aluminum. p-type Ge crystals produced by M. Ya. Dashevskiy and having an aluminum content of $N_a = 2.4 \cdot 10^{14}$, 2.10^{16} , 4.10^{17} , and 3.10^{18} atom/cm⁻¹ were use The Hall effect and resistivity were measured in these samples, and the type of conductivity was determined, the concentration p of the carrier being put equal to Na. The samples were polished by means of M20 (M20) Card 1/4

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The Diffusion of Antimony in Germanium S/181/60/002/009/012/036
Alloyed With Aluminum B004/B056

and M10 (M10) SiC powder, purified, and annealed together with a 1% Ge-Sb alloy in quartz ampoules evacuated to 10⁻³ torr. Annealing temperatures were between 650 and 930°C, and annealing lasted from 2 to 5 days, so that deep penetration of Sb 50 - 300 µ was made possible. In consequence of the diffusion of Sb, a p-n junction occurred at the place where Sb concentration became equal to that of Al, from the position of which the diffusion coefficient D was calculated: $D = x^2/A4t \text{ cm}^2/\text{sec}$ (4) $(x = depth \ of \ the \ p-n \ junction, \ t = duration \ of \ the \ annealing, \ A = a \ con$ stant which was determined for each alloy and temperature). x was determined a) by polishing one side of the sample at angles of 2, 4, or 6° , checked by means of a MMM-6 (MIM-6)18 microscope, and by recording the current-voltage characteristic; b) by polishing plane-parallel layers, recording the current-voltage characteristic, and measuring the thermoemf; c) measuring the resistivity by means of a probe according to Refs. 6,7. The values for x obtained by this method are given in a table. Samples annealed under the same conditions but without the Sb-Ge alloy proved that the thickness of the layer from which Al evaporated, was less by one order of magnitude than x. The results obtained for the four

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The Diffusion of Antimony in Germanium Alloyed With Aluminum

84071 8/181/60/002/009/012/036 B004/B056

Ge samples with different Al contents are represented in Figs. 1-4 as log D = f(1/T). The following was found: D = D₀ exp(- Δ E/RT). In Fig. 5, log D₀ = f(log N_a), and in Fig. 6, Δ E = f(log N_a) is represented. Fig. 7 shows the diffusion isothermal lines log D = f(log p) for 748°, 800°, 840°, and 885°C. At lower temperatures, N_a exerts no influence upon D up to about 10¹⁷ cm⁻³; at 10¹⁸ cm⁻³, D quickly becomes smaller. At higher temperatures, D has a maximum at N_a ~ 10¹⁷ cm⁻³, which is followed by a drop at N_a ~ 10¹⁸ cm⁻³. The increase of D between N_a = 10¹⁴ and N_a = 10¹⁷ cm⁻³ is explained by an internal electric field which forms as a consequence of the high concentration gradient of the impurity diffused in: E_i = (kT/e)(1/C_{Sb})(∂ C_{Sb}/ ∂ x) (8). C_{Sb} is the concentration of antimony and a function of x. At higher temperatures, D is decreased because of intrinsic conductance. There are 7 figures, 1 table, and 10 references: 3 Soviet, 5 US, 1 British, and 1 Czechoslovakian.

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The Diffusion of Antimony in Germanium Alloyed with Aluminum

84071 S/181/60/002/009/012/036 B004/B056

ASSOCIATION:

Institut metallurgii im. A. A. Baykova AN SSSR, Moskva

(Institute of Metallurgy imeni A. A. Baykov of the

AS USSR, Moscow)

SUBMITTED:

April 29, 1959 (initially)
March 5, 1960 (after revision)

Card 4/4

8/181/60/002/009/018/036 воо4/во56

94300

AUTHOR:

Milevskiy, L. S.

TITLE:

The Problem of the Influence of Hardening on the Lifetime

of Minority Carriers in Silicon

PERIODICAL:

Fizika tverdogo tela, 1960, Vol. 2, No. 9, pp. 2158 - 2160

TEXT: By creating an impurity atmosphere at the dislocations in silicon the author endeavored to increase the energy necessary for their transfer and thus to prolong the lifetime τ of the minority carriers. Before hardening, copper of a dilute CuSO₄ solution, to which some HF had been

added, was applied onto samples of n-type silicon having a resistivity of 12-20 ohm.cm and $\tau=120$ - 500 µsec. Before hardening, the samples were heated to $700-800^{\circ}\text{C}$ in a hydrogen atmosphere. The copper deposited on the dislocations, and τ either remained constant or increased somewhat (Fig. 1). The region in which an intense decrease of τ occurs was shifted toward higher temperatures. The dislocations then separated from the impurity atmosphere, and τ quickly became smaller. Fig. 2 shows a

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APPROVED FOR RELEASE: 07/12/2001

CIA-RDP86-00513R001134220018-9"

The Problem of the Influence of Hardening on S/181/60/002/009/018/036 the Lifetime of Minority Carriers in Silicon B004/B056

cross section through a sample. When the hardening of the sample coated with Cu was stopped at 500°C with a remaining $\tau=60-100$ µsec, and by observing the relaxation of τ (Fig. 3), a continuous decrease of τ , i.e., an increase of the concentration of the recombination centers due to dissolution of the cloud of the impurity atmosphere was found. Hardening of the sample at $250-350^{\circ}\text{C}$ led only to a slight increase of τ . The impurity concentrates around the dislocation. There are 3 figures and 7 references: 2 Soviet and 5 US.

ASSOCIATION: Institut metallurgii im. A. A. Baykova AN SSSR, Moskva

(Institute of Metallurgy imeni A. A. Baykov of the

AS USSR, Moscow)

SUBMITTED:

July 27, 1959

Card 2/2

9.4300 (1035, 1138, 1143)

S/181/60/002/009/027/036 B004/B056

AUTHOR:

Milevskiy, L. S.

TITLE:

The Mechanism of the Introduction of Recombination Centers in Germanium and Silicon in Low-temperature Hardening

PERIODICAL:

Fizika tverdogo tela, 1960, Vol. 2, No. 9, pp. 2218-2227

TEXT: It was the aim of this investigation to solve the problem as to whether the lifetime Υ of the minority carriers in Ge and Si is increased if heating before hardening is more and more shortened, i.e., whether there exists a mechanism for the introduction of recombination centers that does not depend on the change in the solubility of impurities. The samples were heated and hardened in helium in a resistance furnace regulated by an $\Im\Pi A - 12$ (EPD-12) potentiometer. Hardening was carried out in cold oil. The impurity atmosphere on the dislocations was produced by annealing the sample in hydrogen after applying copper onto it or after wetting it with $Cu(NO_3)_2$ ("decorating"). Υ was determined from photoconductivity. The forming of recombination centers was investigated within

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The Mechanism of the Introduction of Recombination Centers in Germanium and Silicon in Low-temperature Hardening the range of 250 - 600°C. Already at 350°C hardening leads to a displacement of the dislocations (microphotograph Fig. 1), in which case there is no dependence on the duration of heating (Fig. 2). Fig. 3 shows the effect of hardening upon t in the original silicon and in that treated with Cu. In the latter, the shortening of γ began only at temperatures that were higher by 100° to 150°C. It follows from Fig. 4 that silicon hardened at 450 - 500°C is not stable. In it, T decreases also at room temperature. The data obtained are discussed in detail, reference being made to other papers. The following conclusions were drawn: 1. In low-temperature hardening, a mechanism of the introduction of recombination centers, which is not influenced by diffusion from the sample surface, is active. It is based upon the motion of dislocations due to thermal stresses, in which case the dislocations break away from their impurity atmosphere. The most important effect produced by the interaction between impurities and dislocations is the precipitation of the impurities, by which they lose their electric activity and diminish the recombination effect of the dislocations. The precipitation of impurities causes also stabilization of the dislocations and of T. This stabilization is attained by means of Cu and

Card 2/3

The Mechanism of the Introduction of Recombination Centers in Germanium and Silicon in Low-temperature Hardening 84086 5/181/60/002/009/027/036 B004/B056

Si by hardening at 100 - 150°C, but not higher than 450 - 475°C. The activation energy of the introduction of thermal recombination centers depends on the concentration of the impurities on the dislocations, and is variable within a wide range. By "decorating" the dislocations with impurities, the diffusion coefficient of such impurities may be studied as are able to precipitate on dislocations at temperatures near room temperature. There are 4 figures and 21 references: 13 Soviet and 9 US.

ASSOCIATION: Institut metallurgii im. A. A. Baykova AN SSSR, Moskva

(Institute of Metallurgy imeni A. A. Baykov of the AS USSR.

Moscow)

SUBMITTED:

December 21, 1959



Card 3/3

"APPROVED FOR RELEASE: 07/12/2001 CIA-RDP86-00513R001134220018-9

MILEVSKIY, L. S., Cand. Phys-Math. Sci. (diss) "Formation of Defects of Structure in Rearing of Monocrystals of Silicon and Their Effect on Electrophysical Properties of the Material."

Moscow, 1961, 20 pp (Acad. of Sci. USSR, Physics Institute im P. N. Lebedev) 120 copies (KL Supp 12-61, 252).

MILEVSKIY, L.S.

Pulsations in the rate of growth of a crystal and their effect on the structure and properties of a material produced by Czochralsky's method. Kristallografiia 6 no.2:249-255 Mr-Ap '61. (MIRA 14:9)

1. Institut metallurgii im. A.A.Baykova.
(Silicon crystals--Growth)

S/020/61/141/006/013/021 B104/B112

AUTHORS:

Indenbom, V. L., Nikitenko, V. I., and Mileyskiy, L. S.

TITLE:

Observation of internal stresses around dislocations in

silicon

PERIODICAL:

Akademiya nauk SSSR. Doklady, v. 141, no. 6, 1961.

1360 - 1362

TEXT: The observation of decorated and nondecorated dislocations in silicon by an electron-optical transducer is described. The experimental arrangement consisted of a usual polarization microscope (with Nicol prisms) and a 59M-3 (BEI-3) electron-optical transducer. An OM-24 (OI-24) lamp with infrafilter was used as light source. Dislocations were oriented strictly parallel to the direction of observation by a special breeding method. Crystal breeding was carried out in direction [110]. 2-3 mm thick plates were cut out at right angles to the breeding axis, and polished. As was shown by experiments with polarized light, there exists a birefringence field of rosette-shaped character in the vicinity of dislocations.

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Observation of internal stresses...

S/020/61/141/006/013/021 B104/B112

This agrees with results of a previous paper by V. L. Indenbom et al. (Kristallographiya, 2, 190 (1957)) according to which the birefringence field around dislocations (when the crystal is considered to be isotropic) can be described by the formula $r = C\cos\theta\cos2$ ($\theta - \alpha$). θ is the azimuth counted from the slip plane, α is the angle between this plane and the polarization plane, C is a constant proportional to the marginal component of the Burgers vector of dislocation, to the hardness of the crystal, and to the photoelastics constant. The pattern of microstresses around dislocations changes completely after decorating. The rosette changes, and the signs of birefringence in the individual rosette fields which differed before decorating become equal. Microstresses around decorated dislocations are radially compressed and tangentially elongated. In usual decorating, intensity of the microstresses around dislocations increases somewhat, original microstresses disappear, and curvilinear dislocations may be observed besides rectilinear ones. Only macrostresses produced by the effect of many dislocations are conserved. Redistribution of stresses around dislocations decreases with decreasing impurities. The authors thank Professor M. V. Klassen-Neklyudova for interest and V. D. Khvostikova

Card 2/3

S/020/61/141/006/013/021 B104/B112

Observation of internal stresses...

for assistance in crystal breeding. There are 3 figures and 9 references: 5 Soviet and 4 non-Soviet. The three most recent references to Englishlanguage publications read as follows: W. L. Bond, J. Andrus, Phys. Rev., 101, 1211 (1956); R. Bullough, Phys. Rev., 110, 620 (1958); W. C. Dash, J. Appl. Phys., 29, 705 (1958).

ASSOCIATION:

Institut kristallografii Akademii nauk SSSR (Institute of Crystallography of the Academy of Sciences USSR)
Institut metallurgii im. A. A. Baykova Akademii nauk SSSR (Institute of Metallurgy imeni A. A. Baykov of the Academy of Sciences USSR)

PRESENTED:

June 5, 1961, by A. V. Shubnikov, Academician

SUBMITTED:

May 30, 1961

Card 3/3

33361

\$/181/62/004/001/036/052 B104/B112

24,7500 (1144,1160,1482)

AUTHORS:

Indenbom, V. L., Nikitenko, V. I., and Milevskiy, L. S.

TITLE:

Polarization-optical analysis of the dislocation structure

of a crystal

PERIODICAL: Fizika tverdogo tela, v. 4, no. 1, 1962, 231 - 235

TEXT: The polarization-optical method makes it possible to establish all the characteristics of the dislocation structure in crystals of low dislocation density. A plate with a perpendicular [001] axis, cut out of a Si single crystal parallel to the (110) plane, was used for determining the Burgers vector and for investigating various types of dislocation, such as sessile dislocations (Fig. 2) and dislocations with glide planes coinciding with the (111) and (111) planes (60° dislocations). The formation of sessile dislocations from the 60° dislocations is described by $[101] + \frac{a}{2} [0\overline{11}] \rightarrow \frac{a}{2} [1\overline{10}]$, according to which one 60° dislocation glides along the (111) plane and hits the other 60° dislocation gliding along the (111) plane. The Burgers vectors of the 60° dislocations form Card 1/3/2,

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Polarization-optical analysis of the...

an angle of 120°. The planes of easiest gliding of dislocations form a tetrahedron in a diamond-type lattice. The Burgers vector of the dislocation resulting from the above reaction is perpendicular to the edge of the tetrahedron which is parallel to the dislocation. The atomic mechanism underlying the above reaction is discussed in detail. It is shown that neither the direction of the Burgers vector nor the gliding planes of dislocations formed according to this mechanism coincide with the planes of easiest gliding. V. D. Khvostikov is thanked for having grown the crystal, and Professor M. V. Klassen-Neklyudova for her continuous interest. There are 5 figures and 5 references: 3 Soviet and 2 non-Soviet. The two references to English-language publications read as follows: G. Echart, S. Lederhandler, Bul. Am. Phys. Soc., ser. II, 5, 1, 25, 1960; J. Hornstra, J. Phys. Chem. Sol., 5, 1-2, 129, 1958.

ASSOCIATION: Institut kristallografii AN SSSR Moskva (Institute of

Crystallography, AS USSR, Moscow)

SUBMITTED: August 9, 1961

Card 2/1/2,

S/181/62/004/002/020/051 B101/B102

AUTHOR:

Milevskiy, L. S.

TITLE:

Study of the carrier lifetime at various stages of saturation of impurity atmospheres of dislocations with copper atoms

PERIODICAL: Fizika tverdogo tela, v. 4, no. 2, 1962, 429 - 435

TEXT: In order to evaluate the role of the impurity atmosphere, the tem perature dependence of the lifetime τ of carriers in n- and p-type Si has been studied. The initial dislocation density was 10^3-10^4 per cm². The data for the initial Si were compared with those for Si with an impurity atmosphere saturated with Cu atoms, as well as with data obtained after the disturbance of equilibrium at the dislocations by a heat shock (heat treatment at 500° C and quenching with ethylene glycol). The resistivity of the n-type Si was 15-25 ohmocm, and that of the p-type Si was 95-100 chmocm. The initial lifetime was 75-200 sec. τ was determined from the quenching of the photoconductivity at 10^{-3} mm Hg. The methods of dislocation screening with Cu atoms and the heat shock technique were previously published (FTT, 2, 9, 2218, 1961). Measurement of the Hall effect has Card 1/R

Study of the carrier lifetime...

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shown that the diffusion of Cu in the range of 77 - 550°K changes neither the concentration nor the mobility of the carriers. The temperature dependence of to however, changed after the diffusion of Cu and after the heat shock (Figs. 1 and 2). Dislocation screening reduces their effect on recombination which is determined by impurity centers of unknown origin, which are dissolved in the bulk. Quenching does not alter the Cu concentration, but changes the position of atoms that might affect the recombination process. The impurity atoms become efficient recombination centers if they are located in the region of maximum deformation of the energy band. The adhesion of holes observable in n-type Si with Pd contacts at low temperatures (<2500K) did not occur when using Zn contacts. The function lnt = $f(10^{2}/T)$ exhibited two "plateaux" after the adhesion had been removed. After quenching, the high-temperature plateau vanished, and the curve adopted the same course as in the case of the initial specimen. There are 4 figures and 5 references: 5 Soviet and 1 non-Soviet. The reference to the English-language publication reads as follows: C. B. Collins, R. O. Carlson. Phys. Rev., 108, 6, 1409, 1957.

ASSOCIATION: Institut metallurgii im. A. A. Baykova AN SSSR, Moskva Card 2/4 (Institute of Metallurgy imeni A. A. Baykov, AS USSR, Moscow)

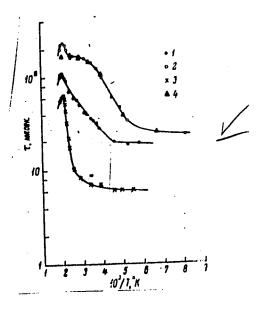
Study of the carrier lifetime...

SUBMITTED: September 4, 1961

Fig. 1. τ as a function of 1/T for p-type Si.

Legend: (1) initial specimen; (2) after diffusion of Cu at 750° C; (3) after thermal shock (valid both for the initial specimen and after diffusion of Cu); (4) theoretical points for recombination at multiply charged centers ($\varepsilon_0 \approx 0.16$ ev); τ , μ sec.

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AUTHOR:

Milevskiy, L. S.

TITLE:

Effect of heat treatment on the lifetime of the carriers in

copper-doped silicon

PERIODICAL: Fizika tverdogo tela, v. 4, no. 3, 1962, 825 - 827

TEXT: Some new data are given on the effect of impurity atmospheres on the carrier lifetime. Specimens of n-type Si, resistivity 10 - 20 ohm·cm, surface dislocation density 10^3 - 10^4 cm⁻² were wetted with a solution of $\text{Cu}(\text{NO}_3)_2$ and annealed in an H_2 atmosphere. The change in lifetime τ was measured (τ_{init} . = 70 - 150 µsec). A maximum increase of τ (up to about 300 µsec) was observed after annealing at 750°C which set in already within the first 20 - 30 min. Thus, the diffusion process of Cu was terminated within this period. The slowly cooled specimens had the same τ . This stable state is, however, disturbed on heating to ~500°C and quenching in ethylene glycol. τ was then found to depend considerably on time. While τ was reduced only slightly by quenching Card 1/3

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Effect of heat treatment...

a considerable reduction was observed in the course of aging at 30 - 50°C (to about 35 - 45 µsec after 6 hrs). Conclusions: (1) the diffusion of Cu prolongs to owing to the formation of a screening impurity atmosphere around the dislocations; (2) subsequent quenching causes a displacement of some dislocations. This could be proved by etching. After the quenching new etching pits were found. The quenched specimen contained not only dislocations screened off by an impurity atmosphere but also dislocations that had left the impurity atmosphere as a result of thermal stresses. (3) These dislocations participate in recombination only slightly. Hence the effect of the dislocations on recombination is a complex function of the number of impurity atoms forming the impurity atmosphere. (4) Recombination effectiveness of the dislocations increases on aging if a chain of recombination centers, e. g., of copper atoms is formed along the dislocation center. There are 2 figures and 10 or income references: 3 Soviet and 7 non-Soviet. The four most references to English-language publications read as follows: A. D. Kurtz, S. A. Kulin, B. L. Aberbach, Phys. Rev. <u>101</u>, 1285, 1956; A. D. Kurtz, S. A. Kulin, B. L. Aberbach, J. Appl. Phys., 27, 1287, 1956; W. Dash, J. Appl. Phys., 27, 1193, 1956; D. T. Stevenson, R. J. Keyes, J. Appl. Phys., 26, 190, 1959. Card 2/3

Effect of heat treatment ...

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ASSOCIATION: Institut metallurgii im. A. A. Baykova AN SSSR, Moskva

(Institute of Metallurgy imeni A. A. Baykov of the AS USSR, Moscow)

SUBMITTED:

January 2, 1962

Card 3/3

14-19-17

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AUTHOR:

Milevskiy, L. S.

77. 11.33:

Interaction of the edge dislocations with the vacancies in

silicon

.. TODICAL:

Fizika tverdogo tela, v. 4, no. 7, 1962, 1878-1881

TEXT: An optical polarization method, as described in FTT, 4, 1, 1962, was used together with selective etching to study the interaction of positive (i) and negative (T) dislocations with point defects in Si single crystal plates (3 mm thick, cut parallel to the main axis). The crystal plates (3 mm thick, cut parallel to the main axis). The (100)-dislocations shown in Fig. 1 are weakly mobile edge-type dislocations, the [111]-dislocations are of the usual sliding (60°) type; both have the same Bûrgers vector of $\vec{b} = \frac{a}{2}$ [110], where a is the lattice constant. The dislocation pair shown in Fig. 1 is of the type as described by Reed in his work on Dislocations in crystals (1957) and are in equilibrium at a temperature near the Si melting point. The diffusion of the dislocation is caused by an absorption of surplus vacancies. Dislocations of a certain

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